

KA7524

LINEAR INTEGRATED CIRCUIT

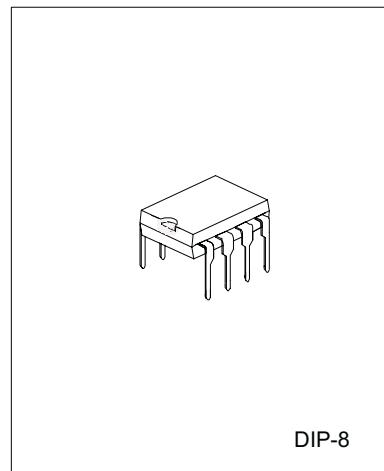
POWER FACTOR CONTROLLER

DESCRIPTION

The Contek KA7524 provides the necessary features to implement the Electronic BALLAST control and S.M.P.S application for designing active power factor correction circuit

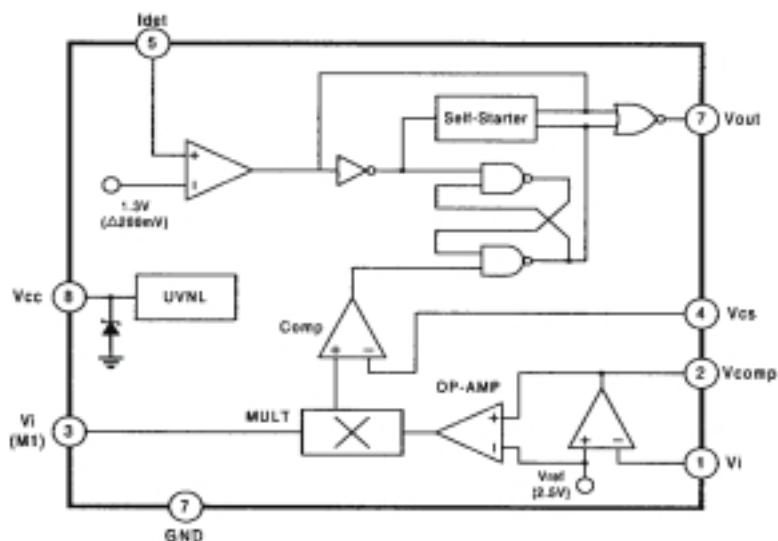
FEATURES

- *Internal self-starting
- *Micro power start up mode
- *Included under voltage lockout circuit
- *Internal 1% reference
- *High output current: peak 500mA



DIP-8

BLOCK DIAGRAM



KA7524**LINEAR INTEGRATED CIRCUIT****ABSOLUTE MAXIMUM RATINGS (Ta=25 °C)**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	Vcc	20	V
Peak Driver Output Current	Io(p)	500	mA
Detect Clamping Diode Current	Idet	10	mA
Output Clamping Diode Current	Io(c.d)	10	mA
Operating Temperature	Topr	-45~65	C
Storage Temperature	Tstg	-65~150	C

ELECTRICAL CHARACTERISTICS (Ta=25 °C)

(All voltage referenced to GND unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Under Voltage Lockout Section						
Start Threshold Voltage	Vth(st)		9.2	10	10.8	V
UV lockout Hysteresis	Vths		1.8	2.0	2.2	V
Supply Zener Voltage	Vz			17		V
Supply Current Section						
Start-up Supply Current	Istart	Vcc<Vth		0.25	0.5	mA
Operating Supply Current	Icc	Vcc=12V, No load		6	12	mA
Dynamic Operating Current	Icc(d)	Vcc=12V, f=50KHZ, Cgs=1000pF		10	20	mA
Reference Section (note 1)						
Reference Voltage	Vref		2.475	2.5	2.525	V
Line Regulation	Vref	12V<Vcc<16V		0.1	10	mV
Load Regulation	Vref	0<Iref<2mA		0.1	10	mV
Temperature Stability	STt			20		mV
Error Amplifier Section						
Input Offset Voltage	Vi0		-15		15	mV
Input Bias Current	Ibias		-1	-0.1	1	µA
Large Signal Open Loop gain	Gv		60	100		dB
Power Supply Rejection Ratio	PSRR		60	86		dB
Output Current	Isource		2			mA
	Isink				-2	mA
Output Voltage range	Vo(p)		1.2		4	V
Unity Gain Bandwidth	UBW			1.0		MHZ
Phase Margin	MPH			57		C

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KA7524**LINEAR INTEGRATED CIRCUIT**ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$) (continued)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Multiplier Section						
M1 Input Voltage Range	$V_i(m1)$		0		2	V
M2 Input Voltage Range	$V_i(m2)$		V_{ref}		$V_{ref}+1$	V
Input Bias Current	I_{bias}		-2	-0.5	2	μA
Multiplier Gain	G_v	$V_i(m1)=0.5V, V_i(m2)=3V$		0.8		/V
Multiplier Gain Stability	ST_t			-0.2		%/C
Current Sense Section						
Input Voltage Threshold	V_{th}		1.0	1.3	1.6	V
Hysteresis	V_{ths}			200		mV
Input Low Clamp Voltage	$V_{ic(L)}$	$I_{det}=0mA$			0.95	V
Input High Clamp Voltage	$V_{ic(H)}$	$I_{det}=3mA$	6.1	7.1		V
Input Current	I_i	$0.8V < V_{det} < 6V$		5		μA
Input Clamp Diode Current	I_{cd}	$V_{det} < 0.9V, V_{det} > 6V$			3	mA
Current Detect Section						
Output Voltage(High)	$V_o(H)$	$I_o=-10mA, V_{cc}=12V$	7	9		V
Output Voltage(low)	$V_o(L)$	$I_o=10mA, V_{cc}=12V$		0.8	1.8	V
Rising Time	t_r	$C_L=1000pF$		100	200	ns
Falling Time	t_f	$C_L=1000pF$		90	200	ns
Self-Start Section						
Self Starting Time	t_{ss}		12			μs

NOTE:

1. Reference can not be tested on the PKG

2. $G_v = V_o(m)/(V_i(m1)*(V_i(m2)-V_{ref}))$ **Contek Microelectronics Co.,Ltd.**

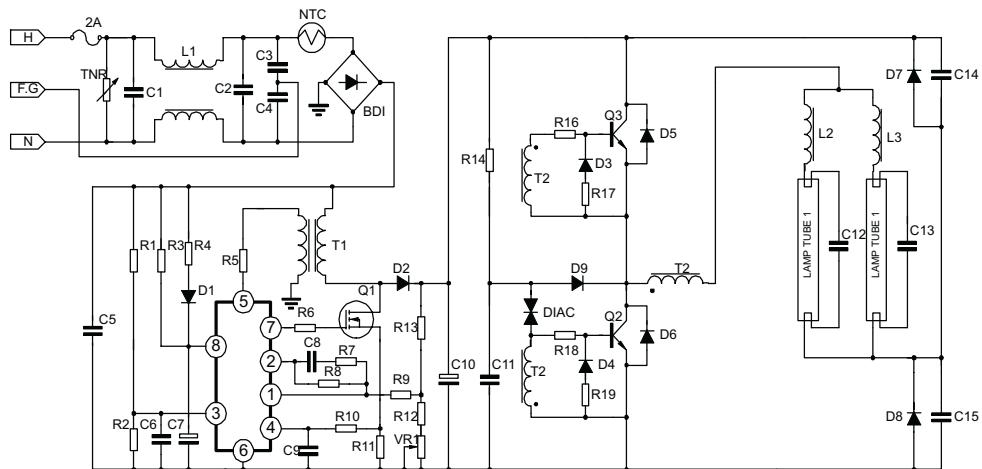
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LINEAR INTEGRATED CIRCUIT

APPLICATION CIRCUIT



PART LIST

Resistor		R16	5.1	Ω	C10	47	$\mu\text{F}/450\text{V}$	D6	FR107
R1	1.8M	R17	27	Ω	C11	0.1	μF	D7	FR107
R2	10K	R18	5.1	Ω	C12	3300pF		D8	FR107
R3	100K	R19	27	Ω	C13	3300pF		BD1	PBP204
R4	3.3	VR1	5K		C14	0.01	μF	TNR	12G471
R5	22K	NTC	10	Ω	C15	0.01	μF	DIAIC	32V
Capacitor									
R7	2.2K	C1	0.1	μF	IC1	Contek KA7524		T1	E1-25(PC30):P=70T
R8	2.2M	C2	0.1	μF	Q1	IRF830		S=4T,Gap=0.5mm	
R9	150K	C3	4700pF		Q2	2SC5039		T2	D15(GP-5):
R10	330	C4	4700pF		Q3	2SC5039		P=3T,S=13T	
R11	0.75	C5	0.1	μF	D1	1N4004		L1	EE-25(Iron Power)
R12	5.1K	C6	0.01	μF	D2	1N4937		80mH	
R13	1M	C7	100	μF	D3	1N4148		L2	EI-25(PC30):
R14	390K	C8	0.1	μF	D4	1N4148		150T,Gap=0.4mm	
R15	3.9M	C9	3300pF		D5	FR107			